

# Timothy D Haeffner

## List of Publications by Year in descending order

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3  
papers

93  
citations

2258059

3  
h-index

2550090

3  
g-index

3  
all docs

3  
docs citations

3  
times ranked

127  
citing authors

#	ARTICLE	IF	CITATIONS
1	Analysis of Bulk FinFET Structural Effects on Single-Event Cross Sections. IEEE Transactions on Nuclear Science, 2017, 64, 441-448.	2.0	45
2	Circuit-Level Layout-Aware Single-Event Sensitive-Area Analysis of 40-nm Bulk CMOS Flip-Flops Using Compact Modeling. IEEE Transactions on Nuclear Science, 2011, 58, 2680-2686.	2.0	24
3	Angular Effects on Single-Event Mechanisms in Bulk FinFET Technologies. IEEE Transactions on Nuclear Science, 2018, 65, 223-230.	2.0	24